


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599911	<b>Applicant(s)/Patent Under Reexamination</b>  CHEON ET AL.
	<b>Examiner</b>  Matthew P Coughlin	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner
564	300	6/3/2009	MPC
564	301	6/3/2009	MPC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Inventor Search	6/3/2009	MPC
STN Search	6/3/2009	MPC
EAST Inventor Search	1/22/2010	MPC
STN Search	1/22/2010	MPC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
564	301, 301	1/22/2010	MPC
544	177,399,165,159	1/22/2010	MPC
549	496,433,65,77,442,58	1/22/2010	MPC
548	204,336.1	1/22/2010	MPC
546	337,338,335,300	1/22/2010	MPC
558	426	1/22/2010	MPC
514	238,2,510,619,640,644,471,365,463,357,438,466,231.5,443,400,351	1/22/2010	MPC

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Examiner,Art Unit 1626